## Notice of References Cited

Application/Control No.	Applicant(s)/Patent Under	
09/695,284	Reexamination HOSHINO ET AL.	
Examiner	Art Unit	
Thang V. Tran	2653 Page 1 of 1	

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,377,536	04-2002	Kim et al.	369/44.23
	В	US-6,343,058	01-2002	Akiyama et al.	369/94
	C	US-6,337,841	01-2002	Kim et al.	369/112.06
	۵	US-6,115,349	09-2000	Tawa et al.	369/44.23
	Е	US-5,982,732	11-1999	Yamanaka, Yutaka	369/44.37
	F	US-5,872,760	02-1999	Kim et al.	369/112.24
	G	US-			
	Н	US-			
	I	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р			-		
	Q					
	R					
	S					
	Т					

## NON-PATENT DOCUMENTS

		NON-I ATEN DOCUMENTS
*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	٧	
	w	
	x	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

